RA2E1/RA2E2 Group

Low Power Application (Use of ADC, DTC and ELC at Snooze mode) for FPB-RA2E1 and FPB-RA2E2

Introduction

This application note describes the features of RA2E1 and RA2E2 MCUs that are useful for low-power operation, typically required for logging data for long durations. The FPB-RA2E1 or FPB-RA2E2 kit is used for creating such a low-power data logging system. The functionality demonstrated here is typically required in products such as fitness trackers, fleet tracking devices, and so forth. The data logger uses the 12-bit A/D Converter (ADC), Data Transfer Controller (DTC), Asynchronous General-purpose Timer (AGT), Real-time Clock (RTC) (Applicable for FPB-RA2E1), Event Link Controller (ELC), Data Operation Circuit (DOC), and Low-power Mode (LPM). The Snooze mode and Software Standby mode are used to reduce power consumption by minimizing the CPU operation time. Application projects use the Integrated Development Environment e² studio IDE and Flexible Software Package (FSP) provided for the RA family.

This application note has been changed to a simple function from application note RA2L1/RA2E1 Group Low Power Application Example (Data Logger) (R30AN0384) so that operation can be confirmed with FPB-RA2E1 and FPB-RA1E2.

Prerequisites

We assume that you have developed Renesas e² studio IDE and Flexible Software Package (FSP). We recommend that you build and run the Blinky project according to section “Tutorial: Your First RA MCU Project – Blinky” in FSP User’s Manual (R11UM0155) prior to trying out this application. You can then become familiar with the e² studio IDE and FSP and verify that the debugging connectivity to the boards is working correctly.

Required Resources

This application project is created for Renesas RA Family MCU RA2E1 and RA2E2. When applying this application note to other MCUs, be sure to change it according to the specifications of the MCU and evaluate it carefully. The resources required for this application project are as follows.

Hardware

- Renesas RA Kit FPB-RA2E1 or FPB-RA2E2
- Seeed Grove Base Shield V2.0 for Arduino (applicable for FPB-RA2E1) (www.seeedstudio.com/Base-Shield-V2.html)
- USB – TTL Serial connector
- Grove Male Jumper wire

Development Tools and Software

- e² studio IDE version 2022-04 or later
- Renesas Flexible Software Package (FSP) version 3.7.0 or later
- GCC ARM Embedded Toolchain version 10.3.1.20210824 or later
- Terminal software (like Tera Term)
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1. Overview

1.1 Overview of Specifications

This application project acquires sensor data and compares it against thresholds at regular intervals. These processes are intermittently executed with Snooze mode during Software Standby mode to achieve operation as a low-power data logger.

In this application project, Snooze mode is entered every 30 minutes during Software Standby mode. While operating in Snooze mode, A/D conversion and the level judgment of the result are performed. After judging the level, the system returns to the Software Standby mode. However, if the conversion result is greater than or equal to the threshold value, Snooze mode is canceled and MCU is transitioned to Normal mode. In addition, the low power mode is canceled every 24 hours, and the measured data accumulated in the buffer is transmitted. After the data transmission, the process repeats. When a user button is pressed, the low power mode is canceled, and the requested data is transmitted. Table 1 explains the details of these processes for each function.

Table 1. List of Functions

<table>
<thead>
<tr>
<th>Function</th>
<th>Process Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>Data Acquisition Function</td>
<td>A/D conversion is triggered by AGT count underflow event, and conversion result are stored in the measurement data buffer.</td>
</tr>
<tr>
<td>Level Judgement Function</td>
<td>The level of A/D conversion results is judged by the Data Operation Circuit (DOC). If the conversion result is greater than or equal to the threshold value, the interrupt is occurred.</td>
</tr>
<tr>
<td>Data Output Function</td>
<td>When the RTC alarm interrupt, external IRQ interrupt and DOC interrupt occur, the mode shifts to Normal mode and the data is output by UART communication.</td>
</tr>
</tbody>
</table>

Note: 1. RTC alarm interrupt available in RA2E1.

Figure 1 shows the RA2E1 MCU states and mode transition events, and Figure 2 shows a conceptual diagram of the operation modes and current consumption for RA2E1.
Note: The current consumption and the duration of each process are conceptual.

Figure 2. RA2E1 Conceptual Diagram of Operation Mode and Current Consumption

Figure 3 shows the RA2E2 MCU states and mode transition events, and Figure 4 shows a conceptual diagram of the operation modes and current consumption for RA2E2.

Figure 3. RA2E2 MCU Status and Mode Transition Events
1.1.1 Data Acquisition Function/Level Judgment Function

In the data acquisition function, the AGT timer interrupt transitions from Software Standby mode to Snooze mode and performs A/D conversion on two channels. The A/D conversion result is stored in the measurement data buffer using the DTC. By DTC transfer completion event, the system returns to Software Standby mode.

Note: 1. In order to create long-term periodic wakeup event, a two-channel connected AGT (16-bit AGT0 + 16-bit AGT1) is used for RA2E1 MCU. RA2E2 MCU can use the single AGTW because AGTW is 32-bit timer.

The level judgement function uses the Data Operation Circuit (DOC) to judge the level of the A/D conversion results. If the conversion result is greater than or equal to the threshold value, the DOC interrupt is occurred and MCU transitions to Normal mode.

The processing sequence for the above functions is described using Figure 5.
1. For RA2E1, the AGT0 timer generates an AGT0 underflow signal at every 1 minute.
2. For RA2E1, the AGT1 timer uses the AGT0 underflow signal as the count source and creates an AGT1 underflow interrupt at 30 counts (every 30 minutes) of this signal. When AGT1 underflow interrupt occurs, it requests a transition to Snooze mode.
3. For RA2E2, the single channel AGTW1 generate the underflow interrupt at every 30 minute which requests a transition to Snooze mode.
4. The ADC starts A/D conversion by a synchronous trigger from the ELC linked event from AGT1 or Snooze request event.
5. When an ADC conversion end interrupt is generated, the DTC performs transfer processing in the following order according to the transfer information set for repeat transfer mode and chain transfer.
   a. The conversion result of A/D converter channel 0 or 19 is transferred to the channel 0 or 19 measurement data buffer.
   b. The conversion result of A/D converter channel 1 or 21 is transferred to the channel 1 or 21 measurement data buffer.
   c. The value of the level judgment threshold storage variable is transferred to the DOC data setting register.
   d. The conversion result of A/D converter channel 1 or 21 is transferred to the DOC data input register.
6. When the level judgment result event (Data Operation Circuit interrupt) of channel 1 or 21 occurs, the Snooze mode is canceled.
7. When a Not DTC transfer completion interrupt (DTC_TRANSFER) is generated due to completion of the transfer processing of step 4, the system returns to the Software Standby mode.

Note: ADC channels 0, 1 are used for RA2E1 and channels 19, 21 are used for RA2E2.
1.1.2 Data Output Function

The data output function transitions from Software Standby mode to Normal mode by RTC alarm interrupt, external IRQ interrupt, and DOC interrupt, and outputs data by UART communication. After the data output is completed, it transits to low power mode. However, if the transition request event to Normal mode is the RTC alarm interrupt, the RTC alarm for the next transition from Software Standby mode to Normal mode is set, and then the mode transitions to the low power mode. The above functions are described in the processing sequence as follows:
1. For the RTC alarm interrupt, external IRQ interrupt and DOC interrupt cancel the low power mode.
2. After the low power mode is canceled, transmit data is generated and the SCI outputs the data.
3. Transits to low power mode after the data output is completed.

Note: RA2E2 MCU does not supports the RTC. To generate 24-hour periodic interval, AGTW0 and IRQ2 are used. AGTW0 configured with periodic timer at 24 hour which generate AGTO output, a jumper wire connected to AGT0 output to IRQ 2 detect the external interrupt on the IRQ2 pin.

1.2 Peripheral Modules of RA2E1 and RA2E2 MCU

Table 2 lists the main peripheral modules of RA2E1 and RA2E2 MCU used in this application project and their typical uses. These are illustrated in the functional overview of RA2E1 MCU in Figure 6 and RA2E2 in Figure 7 respectively.

<table>
<thead>
<tr>
<th>Module</th>
<th>Typical Uses</th>
</tr>
</thead>
<tbody>
<tr>
<td>Low Power Modes</td>
<td>The Snooze mode and the Software Standby mode are used to achieve low power consumption.</td>
</tr>
<tr>
<td>12-bit ADC</td>
<td>Converts the analog continuous time signal from the sensor to a discrete digital signal value.</td>
</tr>
<tr>
<td>DTC</td>
<td>The analog conversion result of the A/D converter is transferred to the buffer using the DTC in repeat transfer mode. A DTC chain transfer is used to transfer the data from the ADC data register, and from RAM/ROM memory to the DOC register for level judgement.</td>
</tr>
<tr>
<td>DOC</td>
<td>Use the subtraction mode to judge the level of the A/D conversion result.</td>
</tr>
<tr>
<td>16-bit AGT 0/1</td>
<td>Generates a transition request to Snooze mode and start data acquisition timing every 30 minutes.</td>
</tr>
<tr>
<td>RTC</td>
<td>Measure the time since power on. The 24-hour alarm interrupt is used to cancel the low power mode and generate the timing of data output.</td>
</tr>
<tr>
<td>SCI</td>
<td>Performs UART communication with the external equipment.</td>
</tr>
<tr>
<td>ELC</td>
<td>Connect a Snooze transition request event or an AGT underflow event to the A/D converter start conversion event.</td>
</tr>
<tr>
<td>32-bit AGTW 0/1</td>
<td>Single channel 32-bit AGTW0 timer with IRQ2 is used to cancel the low power mode and generate the periodic interrupt of data output. Single channel 32-bit AGTW1 underflow event generates a transition request to Snooze mode and start data acquisition timing every 30 minutes</td>
</tr>
<tr>
<td>ICU</td>
<td>The Interrupt Controller Unit (ICU) controls which event signals are linked to the Nested Vector Interrupt Controller (NVIC), and the Data Transfer Controller (DTC) modules. The ICU also controls non-maskable interrupts.</td>
</tr>
</tbody>
</table>

Notes: 1. 16-bit AGT 0/1 available in RA2E1.
2. 32-bit AGTW 0/1 available in RA2E2.
Figure 6. Outline of RA2E1 MCU Function

Figure 7. Outline of RA2E2 MCU Function
2. Description of Functions Used

This section describes the functions of the LPM, ADC, DTC, ELC, AGT, and RTC modules of RA2E1 or RA2E2 MCUs and explains how to set them to achieve the expected operation.

2.1 Low Power Modes

2.1.1 Available Low Power Modes

The table “Operating conditions of each low power mode” in the RA2E1 (R01UH0852) or RA2E2 (R01UH0919) User's Manual describes the conditions to transition to low power modes, the states of the CPUs and peripheral modules, and the condition to cancel each mode. The available low power modes are as follows:

- Sleep mode
- Software Standby mode
- Snooze mode

Figure 8 shows a schematic diagram of the low power mode transitions.

![Figure 8. Schematic Diagram of Low Power Mode Transitions](image)

**2.1.1.1 Sleep Mode**

Generally, CPU operation is the most significant factor for the increase in power consumption. In this mode, the CPU halts operation but retains the value of the CPU's internal registers. Peripheral functions other than CPU are not stopped. The Sleep mode is canceled when an available reset or interrupt occurs in Sleep mode. All interrupt sources are available. When interrupts are used to cancel Sleep mode, the corresponding IELSRn register must be set prior to executing WFI instruction.

**2.1.1.2 Software Standby Mode**

This mode dramatically reduces power consumption by stopping the CPU, most on-chip peripheral functions, and oscillators. However, CPU's internal registers, SRAM data, the on-chip peripheral functions, and I/O port status are retained.

**2.1.1.3 Snooze Mode**

This mode is an extension of Software Standby mode that allows limited peripheral modules to operate with the CPU halted. This reduces current consumption by flexible operation of peripheral modules required by
the application. Snooze mode can be entered from Software Standby mode by a specified interrupt request. Interrupt requests available in Snooze mode can also transition from Snooze mode to Normal mode or Software Standby mode.

2.1.2 Low Power Mode Transition Events

For details on the available low power mode transitions, refer to the relevant sections in the RA2E1 (R01UH0852) or RA2E2 (R01UH0919) User's Manual below.

- Table: Available Snooze requests to switch to Snooze mode.
- Table: Available Snooze end requests (triggers to return to Software Standby mode).
- Table: Available interrupt sources to transition to Normal mode from Snooze mode and Software Standby mode.

Table 3 lists the mode transition events used in this application project. Figure 9 also shows the low power transition event settings on FSP configurator.

Table 3. Mode Transition Events Used in this Application Project

<table>
<thead>
<tr>
<th>Transition Request</th>
<th>Event</th>
</tr>
</thead>
<tbody>
<tr>
<td>Request for transition to Snooze mode</td>
<td>AGT1_AGTI</td>
</tr>
<tr>
<td>Snooze mode end request</td>
<td>DTC_TRANSFER</td>
</tr>
<tr>
<td>Request for transition to Normal mode from Snooze mode</td>
<td>PORT_IRQ1</td>
</tr>
<tr>
<td>or Software Standby mode</td>
<td>PORT_IRQ2</td>
</tr>
<tr>
<td></td>
<td>RTC_ALM</td>
</tr>
<tr>
<td></td>
<td>DOC_DOPCI</td>
</tr>
</tbody>
</table>

Notes: 1. Applicable for RA2E2.
2.2 12-Bit A/D Converter

The RA2E1 and RA2E2 MCU include a 12-bit successive approximation A/D converter (ADC12) unit. There are three types of scan conversion operation modes and two types of conversion modes as shown below.

- **Single scan mode**: Executes the scan of the specified channel once.
- **Continuous scan mode**: Scanning of the specified channels is repeated until ADCSR.ADST bit is set to 0 by software.
- **Group scan mode**: The scan of the channel selected in Groups A and B is executed once by the synchronous trigger.
- **High-speed A/D conversion mode**: Executes A/D conversion at high speed.
- **Low-power A/D conversion mode**: The A/D conversion time is longer than the high-speed conversion mode, but it executes with low power consumption.

Note: 1. Refer to section “Analog Input Sampling and Scan Conversion Time” and Table “Operating and standby current” in the RA2E1 (R01UH0852) or RA2E2 (R01UH0919) User's Manual for a deep understanding of the difference between A/D conversion modes.

### 2.2.1 A/D Conversion Channel

The 12-bit A/D converter unit (ADC12) can select up to 13 channels (AN000–AN010, AN017–AN022)*1 of analog input, temperature sensor, internal reference voltage, or CTSU TSCAP voltage for RA2E1 and up to 8 channels (AN005, AN006, AN009, AN010, AN019–AN022)*2 of analog input, temperature sensor, internal reference voltage for RA2E2.

Notes 1, 2: The available input channels depends on a package type.
2.2.2 Analog Pin Connection for FPB-RA2E1

The application project uses Seeed’s Grove Base Shield V2.0 for Arduino to connect the sensor through Arduino compatible connector of FPB-RA2E1 kit. J6-1 and J6-2 of Arduino compatible connector of FPB-RA2E1 are connected to analog channels 0 (AN000) and 1 (AN001) of the RA2E1 MCU, and can be read by selecting channels 0 and 1. Figure 10 shows the analog signal pin connections for Arduino compatible connectors in FPB-RA2E1 kit. Figure 11 shows the ADC scan channels settings in FSP configurator.

The A/D conversion channel is selected by the ADANSA0, ADANSA1 register. A/D conversion starts from the smallest channel number according to the conversion sequence for the analog input channel (ANn). The A/D conversion result is stored in the corresponding A/D data register n (ADDRn).

![Arduino Uno](image1)

Figure 10. FPB-RA2E1 Kit Arduino-Compatible Connector Analog Signal Pin Connection

![Figure 11. FPB-RA2E1 ADC Scan Channels Settings on FSP Configurator](image2)

2.2.3 Analog Pin Connection for FPB-RA2E2

The application project uses a PMOD1 connector to connect the sensor through the grove-male jumper wire in FPB-RA2E2 kit. Both signal pins of the sensors module are connected to analog channels 19 (AN019) and 21 (AN021) of RA2E2 MCU, and can be read by selecting channels 19 and 21. Figure 12 shows the analog signal pin connections in FPB-RA2E2 kit. Figure 13 shows the ADC scan channels settings in FSP configurator.
The A/D conversion channel is selected by the ADANSA0, ADANSA1 register. A/D conversion starts from the smallest channel number according to the conversion sequence for the analog input channel (ANn). The A/D conversion result is stored in the corresponding A/D data register n (ADDRn).

![Figure 12. FPB-RA2E2 kit PMOD1 Connection with Analog Sensors](image)

**Figure 12.** FPB-RA2E2 kit PMOD1 Connection with Analog Sensors

A/D conversion of a synchronous trigger from the ELC can be started by the preset event of the ELC specified by the ELSRn register as shown below. Set ADCSR.TRGE bit to 1 and ADCSR.EXTRG bit to 0 and select the corresponding source in ADSTRGR.TRSA[5:0] and ADSTRGR.TRSB[5:0] bits.

- Select ELC_AD00 in the ELC. ELSR8 register
- Select ELC_AD01 in the ELC. ELSR9 register

![Figure 13. FPB-RA2E2 ADC Scan Channels Settings on FSP Configurator](image)

**Figure 13.** FPB-RA2E2 ADC Scan Channels Settings on FSP Configurator

### 2.2.4 Conversion Start Event

Figure 14 shows ADC12 Input/Output events. The ADC12 conversion start condition can be selected from three triggers: software trigger, synchronous trigger from ELC, and asynchronous trigger by external trigger ADTRG0 pin. In this application project, the synchronous trigger from the ELC is selected as the conversion start condition. Figure 15 shows the A/D conversion start trigger event settings in FSP configurator.

A/D conversion of a synchronous trigger from the ELC can be started by the preset event of the ELC specified by the ELSRn register as shown below. Set ADCSR.TRGE bit to 1 and ADCSR.EXTRG bit to 0 and select the corresponding source in ADSTRGR.TRSA[5:0] and ADSTRGR.TRSB[5:0] bits.

- Select ELC_AD00 in the ELC. ELSR8 register
- Select ELC_AD01 in the ELC. ELSR9 register
2.2.5 Data Register Automatic Clearing Function

When the A/D data register is read by the CPU or DTC, the A/D data register (ADDRn, ADRD, ADDBLDR, ADDBLDRA, ADDBLDRB, ADTSDR, ADOCDR) can be automatically cleared to 0x0000 by setting ADCER.ACE bit to 1. Figure 16 shows the ADC data register auto clearing function settings in FSP configurator.

In this application project, the value of the data register (ADDR0) must be read twice in order to transfer the conversion result of A/D converter channel 0 or 19 to the two data areas. Therefore, the data register automatic clearing function is disabled (set the ACE bit in ADCER to 0).
2.3 DTC Transfer

When the data transfer controller (DTC) is activated by an interrupt request, it transfers data according to the transfer information. To operate DTC, the data to be transferred must be stored in SRAM area in advance.

The following three transfer modes are available:

- **Normal transfer mode**: One data transfer is performed by one activation.
- **Repeat transfer mode**: One data transfer is performed by one activation. When data of repeat size is transferred, it returns to the address at the start of transfer.
- **Block transfer mode**: One block is transferred at one activation.

### 2.3.1 Transfer Start Event

The DTC can be activated by an interrupt request. When IELSRn.DTCE bit in ICU is set to 1, DTC is activated by the corresponding interrupt. The selector output number n (n = 0 to 31) set in IELSRn register in ICU is defined as the interrupt vector number. For the enabled interrupt, a particular DTC interrupt source corresponding to each interrupt vector number n is selected by IELSRn.IELS[4:0] (n = 0 to 31) bits in the ICU.

Figure 17 shows DTC activation by an interrupt request from a peripheral module. Figure 18 also shows the DTC transfer start event settings in FSP configurator.
2.3.2 Chain Transfer

The DTC can perform chain transfers in which multiple data transfers are performed continuously for a single activation source. When CHNE bit in MRB is set to 1, this chain transfer is enabled.

In this application project, the following transfer is executed by one activation factor. Figure 19 shows the chain transfer operation in this case.

- The conversion result of A/D converter channel 0 or 19 is stored in the channel 0 or 19 measurement data buffer.
- The conversion result of A/D converter channel 1 or 21 is stored in the channel 1 or 21 measurement data buffer.
- The value of the level judgment threshold storage variable is stored in the DOC data setting register.
- The conversion result of A/D converter channel 1 or 21 is stored in the DOC data input register.

![DTC Transfer Start Event Settings in FSP Configurator](image)

**Figure 18. DTC Transfer Start Event Settings in FSP Configurator**

![Chain Transfer Operation](image)

**Figure 19. Chain Transfer Operation**

When chain transfer is set using the DTC driver of the FSP, the transfer information can be declared as an array of transfer_info_t structures, and the pointer of the first transfer information can be passed to the driver. At this time, the member chain_mode of all transfer_info_t structures except for the last transfer, must be set to TRANSFER_CHAIN_MODE_EACH or TRANSFER_CHAIN_MODE_END and configured for chain mode. Set the chain_mode of the last transfer to TRANSFER_CHAIN_MODE_DISABLED.
Since the FSP Configurator does not allow creation of chained Transfer Control Blocks, the R_DTC_Reconfigure function should be used to override the FSP defined transfer_info_t data passed through the transfer_cfg_t data structure instance.

The chain transfer shown in Figure 19 is set as follows.

```c
transfer_info_t g_dtc_data_transfer_info[4] = {
    {
        .dest_addr_mode = TRANSFER_ADDR_MODE_INCREMENTED,
        .repeat_area = TRANSFER_REPEAT_AREA_DESTINATION,
        .irq = TRANSFER_IRQ_END,
        .chain_mode = TRANSFER_CHAIN_MODE_EACH,
        .src_addr_mode = TRANSFER_ADDR_MODE_FIXED,
        .size = TRANSFER_SIZE_2_BYTE,
        .mode = TRANSFER_MODE_REPEAT,
        .p_dest = address of the channel 0 data buffer,
        .p_src = address of ADC channel 0 data register,
        .num_blocks = 0,
        .length = size of the channel 0 data buffer,
    },
    {
        .dest_addr_mode = TRANSFER_ADDR_MODE_INCREMENTED,
        .repeat_area = TRANSFER_REPEAT_AREA_DESTINATION,
        .irq = TRANSFER_IRQ_END,
        .chain_mode = TRANSFER_CHAIN_MODE_EACH,
        .src_addr_mode = TRANSFER_ADDR_MODE_FIXED,
        .size = TRANSFER_SIZE_2_BYTE,
        .mode = TRANSFER_MODE_REPEAT,
        .p_dest = address of the channel 1 data buffer,
        .p_src = address of ADC channel1 data register,
        .num_blocks = 0,
        .length = size of the channel1 data buffer,
    },
    {
        .dest_addr_mode = TRANSFER_ADDR_MODE_FIXED,
        .repeat_area = TRANSFER_REPEAT_AREA_DESTINATION,
        .irq = TRANSFER_IRQ_END,
        .chain_mode = TRANSFER_CHAIN_MODE_EACH,
        .src_addr_mode = TRANSFER_ADDR_MODE_FIXED,
        .size = TRANSFER_SIZE_2_BYTE,
        .mode = TRANSFER_MODE_REPEAT,
        .p_dest = address of the DOC data setting register,
        .p_src = address of the level judgment threshold storage variable,
        .num_blocks = 0,
        .length = 1,
    },
};
```
{  
    .dest_addr_mode = TRANSFER_ADDR_MODE_FIXED,  
    .repeat_area = TRANSFER_REPEAT_AREA_DESTINATION,  
    .irq = TRANSFER_IRQ_END,  
    .chain_mode = TRANSFER_CHAIN_MODE_DISABLED,  
    .src_addr_mode = TRANSFER_ADDR_MODE_FIXED,  
    .size = TRANSFER_SIZE_2_BYTE,  
    .mode = TRANSFER_MODE_REPEAT,  
    .p_dest = address of the DOC data input register,  
    .p_src = address of ADC channel 0 data register,  
    .num_blocks = 0,  
    .length = 1,  
};

Note: A/D channels 0, 1 are used in RA2E1 and channels 19, 21 used in RA2E2.

2.4 DOC Subtraction Mode

The Data Operation Circuit (DOC) compares, adds, or subtracts 16-bit data. If the selected condition is met, an interrupt request is generated. There are three types of interrupt occurrence conditions that can be selected as follows:

- The compared values either match or mismatch
- The result of data addition is greater than 0xFFFF
- The result of data subtraction is less than 0x0000

Figure 20 shows the DOC function settings in FSP configurator.

![Figure 20. DOC Function Settings on FSP Configurator](image)

In this application project, when the measured data is greater than or equal to the threshold value, the level judgment operation uses the DOC subtraction mode to generate an event. The procedure for determining the level using the DOC subtraction mode is shown below. Figure 21 shows the states of the registers at that time.

Procedure for the level judgement using DOC subtraction mode:

1. The threshold of the level judgment is stored in the data setting register (DODSR).
2. The conversion result of A/D converter channel 1 or 21 is stored in the data input register (DODIR).
3. If the difference is less than 0x0000, DOCR.DOPCF flag is set to 1.
### 2.5 ELC Event Connection

The ELC uses event signals/indications generated by peripheral modules as source signals and passes them to other modules to provide direct linkage between modules without interrupting the CPU operation. As a result, Interrupt Service Routines to the CPU from the event generating module are not required.

When event linking is used, set the ELS[7:0] bits in ELSRn for the module to which the event is linked. Also, ELCR.ELCON bits are set to 1 to enable all event links. Refer to Table “Association between event signal names set in ELSRn.ELS[7:0] bits and signal numbers” in the RA2E1 (R01UH0852) or RA2E2 (R01UH0919) User's Manual for the event number to set in ELSRn register.

As described above, this application project uses the synchronous trigger from the ELC as the A/D conversion start trigger. Also, in this application project, the event that triggers the ADC conversion start changes according to the state of the low power mode. In Snooze or Software Standby mode, connect the Snooze request event to ADC12. Otherwise, connect AGT1 underflow interrupt to ADC12. Figure 22 shows the event connection in the ELC module at that time.
The ELC event connection can be configured in the FSP Configurator. Some ELC event connections (Example: ADC12 scan start event) can be conveniently configured from the Properties view which is visible upon selecting the module seen on the Stacks tab. The ELC Allocation setting status can be checked with allocations by opening Event Links as shown in Figure 23. To set additional links, set them from User Events Consumed > New User Event. As shown in the figure below, we have added settings for port-out that cannot be set on the Stacks tab.

![Figure 22. ELC Event Connection for ADC Start Conversion](image)

In Normal mode

In Snooze mode or Software Standby mode

![Figure 23. ELC Connection Settings on the Configurator](image)
2.6 Two-Channel Connected AGT in RA2E1

RA2E1 MCU implements a 16-bit Asynchronous General Purpose Timer (AGTn) with two channels (n=0, 1). This AGT can be used over a two-channel connection to generate a long-period interrupt (Figure 24). To connect to two channels, select the underflow event signal from AGT0 (101b) as the count source in the AGT1.AGTMR1.TCK bit. However, the only combination that can be selected is the one that uses the AGT0 underflow event signal as the count source of AGT1. Refer to the relevant part of the RA2E1 User’s Manual (R01UH0852) for more information. Figure 25 also shows AGT count source settings in FSP configurator.

![Figure 24. Two-Channel Connected AGT](image)

The maximum period for a single-channel AGT during software standby mode is 256 seconds (approximately 4.3 minutes) when AGTLCLK or AGTSCLK is selected as the count source and 1/128 as the clock frequency division ratio. For a two-channel AGT, the maximum period is approximately 16,777,216 seconds (approximately 194 days).

In this application project, a two-channel AGT is used because it is necessary to generate a periodic interrupt every 30 minutes as a transition request to Snooze mode and the timing of data acquisition.

2.7 Two-Channel AGTW and IRQ2 in RA2E2

RA2E2 MCU implements 32-bit Asynchronous General Purpose Timer (AGTWn) with two channels (n=0, 1). The AGTW 0 is used as periodic timer with pin output enabled (looped with IRQ2 pin which acts as a wake source from standby mode) to generate a long-period interrupt (Figure 26). With the AGT00 signal connected to the external interrupt 2 (IRQ2) through the jumper wire, IRQ2 interrupt acts as wake up source from the software standby mode to output the stored date at regular interval of 24 hours. Refer to the relevant part of the RA2E2 User’s Manual (R01UH0919) for more information.
Figure 26. AGTW0 Timer and IRQ2 for Periodic Data Output

The RA2E2 AGTW1 32-bit single channel timer is used to generate the snooze request through the AGT1 underflow event at 30 minutes of interval as show in Figure 27.

Figure 27. AGTW1 Timer for Snooze Request

Figure 28 and Figure 29 show AGT1, AGT0 count source settings in the FSP configurator.

Figure 28. AGT1 Count Source Settings in FSP Configurator

Figure 29. AGTW0 Count Source, Pin Output Settings in FSP Configurator

2.8 RTC Mode Selection for RA2E1

The RTC has two operation modes and two count modes.
Operation modes include normal operation mode and low-power consumption clock mode. Some features are limited in low-power modes. For more information, see Table “RTC specifications” in RA2E1 User's Manual (R01UH0852).

RCR4.ROPSEL can be used to select the operating mode. In this application project, the normal operation mode is selected to use the RTC alarm interrupt (RCR4.ROPSEL is set to 0).

There are two counting modes: calendar count mode and binary count mode. The calendar count mode retains the 100-year calendar from 2000 to 2099 and automatically corrects the leap year date. In binary count mode, seconds are counted, and the information is saved as a serial value. In this application project, the binary count mode is selected to measure the time (elapsed seconds) since startup.

The count mode can be selected by using the RCR2.CNTMD bit. When this bit is rewritten, the next process is performed after confirming that the value has been rewritten. If the count mode is set again, the RTC software reset is executed and it redoes the initial settings. This bit is updated synchronously with the count source, but the count mode is switched after an RTC software reset.

2.9 Clock Output
This application project allows checking the status of the low power mode by outputting the clock externally. This is possible because some oscillators stop in Software Standby mode.

The clock sources output from CLKOUT pins and their division factors are set by the registers below. To enable outputting from CLKOUT pin, set CKOCR.CKOEN to 1. The FSP configurator sets the clock output from the Clocks tab as shown in Figure 30.

- CKOCR.CKODIV[2:0], or CKOCR.CKOSEL [2:0]
- OFS1.HOCOFRQ1[2:0]

![Figure 30. Clock Output Settings in FSP Configurator](image)

3. Low-Power Data Logger Application
This chapter describes the detailed design of the low-power data logger application using the module features described in the previous chapter.

3.1 Functional Specification
This application project is implemented based on the following specifications. Figure 31 also shows the overall algorithm for the low-power data logger.
3.1.1 Data Acquisition Function
- Analog signals of two sensors (Illuminance sensor Seeed Grove-Luminance Sensor, Temperature sensor Seeed Grove-Temperature Sensor) connected to external pins are acquired by A/D converters.
- Analog signal input values are between the low-potential reference voltage (VREFL and VSS) and the high-potential reference voltage (VREFH and VCC) set between 0 V and 3.3 V respectively.
- Acquisition of data from each sensor is performed every 30 minutes regardless of the low power mode status (using Snooze request event or AGT1 underflow interrupt).
- The size of the measurement data buffer is 96 samples (48 hours of sampling every 30 minutes).

3.1.2 Data Level Judgement Function
- After acquiring the data, the analog signal pin AN001 (For FPB-RA2E1 application) or AN021 (For FPB-RA2E2 application) judges the level by DOC.
- When AN001 (For FPB-RA2E1 application) or AN021 (For FPB-RA2E2 application) is equal to or greater than the threshold (30.00°C), the low power mode is canceled and data is output.

3.1.3 Data Output Function
- Perform data output every 24 hours triggered by RTC alarm interrupt (For FPB-RA2E1 application) or external IRQ interrupt generated by AGT0 signal loopback (For FPB-RA2E2 application), external IRQ interrupt generated by user switch and DOC interrupt.
- UART communication format is 115,200 bps baud rate, 8-bit data length, no parity, 1 stop bit.
Figure 31. Overall Algorithm of the Low-Power Data Logger
3.2 User Interface

This section describes the user interface for the Low-Power Data Logger Application. See chapter 4.3 "Procedure for Checking the Operation of the Low-power Data Logger" for more information of checking operation using the main module.

Figure 32 and Figure 33 shows the system overview of this application project.

3.2.1 Connecting the Sensor

In FPB-RA2E1 application project, attach Seeed’s Grove Base Shield V2.0 for Arduino-to-Arduino compatible connector of FPB-RA2E1 kit. Attach the sensor module to the A0 and A1 connectors of this Base Shield with Grove cable. This connects the analog signal pins (AN000 and AN001) of RA2E1 MCU with the analog output pins of the two sensors. Refer to Figure 34.
In FPB-RA2E2 application project, PMOD1 connector of FPB-RA2E2 kit connects the sensor module to the analog signal pins (AN019 and AN021) with the analog output pins of the two sensors using jumper wires. Refer to Figure 35.

- Light Sensor Module: Seeed Grove – Luminance Sensor
  Equipped with illuminance sensor APDS-9002, Operating voltage: 2.4–5V, Measurement range: 0–1000Lux
- Temperature Sensor Module: Seeed Grove – Temperature Sensor
  Equipped with NTC thermistor NCP18WF104F03RC, Operating voltage: 3.3–5V, Operating temperature range: -40 °C – 125°C

Table 4 and Figure 36 show the connection pins to the USB-TTL connector. Connect Arduino-compatible connector of FPB-RA2E1 kit using jumper wires.

<table>
<thead>
<tr>
<th>RA2E1 Pin</th>
<th>FPB-RA2E1 Pin</th>
<th>Typical Uses</th>
</tr>
</thead>
<tbody>
<tr>
<td>P101/TxD0</td>
<td>J1-4</td>
<td>Serial communication (transmission). Connect to the RXD pin of the USB-TTL connector.</td>
</tr>
<tr>
<td>VSS</td>
<td>GND</td>
<td>Ground. Connect to the GND pin of the USB-TTL connector.</td>
</tr>
</tbody>
</table>
3.2.3 Hardware Setup for AGTW Signal Loopback (For FPB-RA2E2 Application)

Table 6 and Figure 37 show the connection pins to loopback the AGTW0 output pin P102 and external IRQ pin P100.

Table 6. Pins to be Connected for AGTW0 signal loop-back (FPB-RA2E2 kit)

<table>
<thead>
<tr>
<th>RA2E2 Pin</th>
<th>FPB-RA2E2 Pin</th>
<th>Typical Uses</th>
</tr>
</thead>
<tbody>
<tr>
<td>P102 (AGTW0) loopback with P100 (IRQ2)</td>
<td>J1-6 and J1-5</td>
<td>AGTW0 output pin loopback with IRQ2 pin for periodic wake up.</td>
</tr>
</tbody>
</table>
3.2.4 Data Communication Specifications

This application project performs data communication according to the following procedure and format.

3.2.4.1 Communication Data Format

- Transmission Format
  The following is the packet format/protocol of data transmitted by the FPB-RA2E1 and FPB-RA2E2.
  Packet format:

<table>
<thead>
<tr>
<th>Description</th>
<th>Code</th>
<th>Length</th>
<th>Function</th>
</tr>
</thead>
<tbody>
<tr>
<td>(a) Start code</td>
<td>'^'</td>
<td>1 byte</td>
<td>Start of the packet</td>
</tr>
<tr>
<td>(b) Attribute code</td>
<td>ASCII Code</td>
<td>1 byte</td>
<td>Represent a data output occurrence event</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>'1': RTC alarm event or IRQ 2 event</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>'2': External IRQ event</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>'3': DOC interrupt event</td>
</tr>
<tr>
<td>(c) Delimiter code</td>
<td>','</td>
<td>1 byte</td>
<td>Code delimiting code</td>
</tr>
<tr>
<td>(d) Data length code</td>
<td>ASCII Code</td>
<td>4 bytes</td>
<td>Indicates the length of the data section.</td>
</tr>
<tr>
<td>(e) Data</td>
<td>ASCII Code</td>
<td></td>
<td>Number of bytes specified in (d)</td>
</tr>
<tr>
<td>(f) End code</td>
<td>'$'</td>
<td>1 byte</td>
<td>End of the packet</td>
</tr>
<tr>
<td>(g) Linefeed code</td>
<td>'n'</td>
<td>1 byte</td>
<td>Linefeed</td>
</tr>
</tbody>
</table>

(e) Data format

The format of the data part varies depending on the attribute code as shown below.
• Attribute code 1/2 (output data by RTC alarm\IRQ 2 and external IRQ interrupt)
  Format of data part:

  | Time data | ',' | Number of data | ',' | First data | ',' | Second data | ',' | ... | ',' | Last data |
  | Light     | Data |                 |     | Temperature Data |
  

• Attribute code 3 (output data by DOC interrupt)
  Format of data part:

  | Time data | ',' | Light data | '/' | Temperature data |

The data comprising the format of attribute codes 1 to 3 is generated as follows.

- The data count consists of 0 to 9 ASCII codes. The length is 2 bytes. Example: When the system transmits 10 data, it sets 0x31, 0x30.
- The time/light/temperature data consists of 0 to 9 ASCII codes. Example: When the system transmits a time value “1234”, it sets 0x31, 0x32, 0x33, 0x34.
- The time data is composed of 10-digit decimal number representing elapsed time.
- The light and temperature data are composed of 4-digit decimal number representing ADC read value. When the system transmits data “2000”, it sets 0x32, 0x30, 0x30, 0x30.
- The delimiter between the code is ‘,’. The delimiter between the time and light data is ‘/’.

Note: Time data and preceding delimiter code not available in protocol format of FPB-RA2E2 application as it does not have RTC module.

### 3.2.5 Input/Output Pins for Debugging (FPB-RA2E1 and FPB-RA2E2 kit)
Table 7 and Figure 38 show the I/O pins for debugging this application project. The debug pins can be observed and toggled as shown below to cancel the low power modes and check the status of the modes.

#### Table 7. Debugging I/O Pins (FPB-RA2E1/FPB-RA2E2 kit)

<table>
<thead>
<tr>
<th>RA2E1/RA2E2 Pin</th>
<th>FPB-RA2E1/FPB-RA2E2 Pins or Connecting Components</th>
<th>Typical Uses</th>
</tr>
</thead>
<tbody>
<tr>
<td>P109/CLKOUT</td>
<td>J5-2</td>
<td>Clock output</td>
</tr>
<tr>
<td>P914</td>
<td>LED2</td>
<td>Turn on in Normal mode</td>
</tr>
<tr>
<td>P015</td>
<td>LED1</td>
<td>Error condition turn on when API call failed</td>
</tr>
<tr>
<td>P205/IRQ1</td>
<td>User switch S1</td>
<td>Manual cancellation of low power mode</td>
</tr>
</tbody>
</table>
3.3 Clock Input (For RA2E1)

The clock from the external oscillator must be input in order for the RTC or AGT to perform an accurate time count. FPB-RA2E1 kit implements a 32.768-kHz clock crystal, but by default, it is not connected to the RA2E1 MCU by solder jumpers (E19 and E20). Therefore, the project attached with this application note selects an internal clock (LOCO) as the count source for AGT0 and RTC.

When accurate time counting is required, connect the external oscillator using solder bridges. Also, the following settings should be changed:

- Change the sub-clock populating setting to “Populated” in the **BSP** tab in the FSP configurator.
- Change the count source for AGT0 to “SUBCLOCK” in the **Stacks** tab in the FSP configurator.
- Change the count source for RTC to the sub-clock in `rtc_initialize()` in `app_common.c`.

Note: RA2E2 MCU does not support an external oscillator.

Figure 39 and Figure 40 show the positions of the solder jumpers for external oscillator connections.
3.4 Debugging

This application project implements pin input/output function for checking the low power mode status, fast cycle debug function, and disable sensor dependent process function.

3.4.1 Canceling the Low Power Mode by Pressing Down the User Switch

The user switch S1 of FPB-RA2E1 or FPB-RA2E2 can be pressed to generate an IRQ1 interrupt and cancel the low power mode. Setting a breakpoint after canceling stops the program being executed, and each register and data can be checked.

3.4.2 Checking the Low Power Mode Status

The low power mode status can be checked by observing LED2 and CLKOUT pin.

When LED2 is turned on, the mode is Normal. In Software Standby mode, HOCO, MOCO, and MOSC clocks are stopped. Therefore, when these clocks are set as the clock output source, CLKOUT pin retains either High or Low state. When toggling out, the mode is changed to Normal mode or the low power mode other than the Software Standby mode. When the debugger is connected, the clock does not stop even if Software Standby mode is entered. Disconnecting the debugger is required to check the mode status.

In addition, port P109 (CLKOUT pin) of the FPB-RA2E1 or FPB-RA2E2 kit is connected to the onboard E2 emulator by default. If this pin is used for clock output, disconnect solder jumpers (E25 and E29) as needed.

Figure 43 shows the position of the solder jumper for connecting the P109 (CLKOUT pin) to the onboard E2 emulator.

Table 8 lists the pin output states in each low power mode, and Figure 41 and Figure 42 show examples of pin outputs in each low power mode.

Table 8. Pin Output States in each Low Power Mode

<table>
<thead>
<tr>
<th>Low Power Modes</th>
<th>P109/CLKOUT</th>
<th>P914/LED2</th>
</tr>
</thead>
<tbody>
<tr>
<td>Normal mode</td>
<td>Toggle</td>
<td>High</td>
</tr>
<tr>
<td>Software Standby</td>
<td>High or Low</td>
<td>Low</td>
</tr>
<tr>
<td>Snooze mode</td>
<td>Toggle</td>
<td>Low</td>
</tr>
</tbody>
</table>

Figure 41. Example of Pin Output in Snooze Mode
3.4.2.1 Fast Cycle Debug

This sample project implements a function to speed up the execution cycle of data acquisition and data processing in order to check the operation in a short time. To enable this feature, define the `DEBUG_FAST_CYCLE` macro in the `app_common.h`. When this `DEBUG_FAST_CYCLE` macro is defined, the following process is enabled, and the data acquisition period is set every 30 seconds and the data processing period is set every 24 minutes.

- Resetting the AGT0 timer count (AGT)
- Changing the Added Value of the RTC Alarm Setting

Note: In the FPB-RA2E2 application, AGTW0 at 24-minute and AGTW1 at 30second intervals are configured with `DEBUG_FAST_CYCLE` mode.

3.5 Flowchart

This section describes the flowchart of the Low-Power Data Logger Application for the case of FPB-RA2E1. For the FPB-RA2E2 application, please refer to the source code.
Figure 44 shows the overall flow of the application project.

![Overall Flow Diagram]

- **Power on**
  - **Module initialization**
    - (a) Initialize module
  - **Pin state change function pin_state_change()**
    - (b) Initialize external output pin
  - **AGT timer start function agt_start()**
    - (c) Start AGT timer count
  - **RTC alarm setting function rtc_alarm_set()**
    - (d) Set RTC alarm (only in RA2E1)

**Figure 44. Overall Flow**
Figure 45 shows the module initialization processing flow.

![Module Initialization Processing Diagram]

- **ADC initialize function**
  - Open function \( R_{ADC\_Open}() \)
  - Configure ADC scan parameter
  - Enable compare function to use ADC12 in Snooze mode
- **LPM initialize function**
  - Open function \( R_{LPM\_Open}() \)
- **ICU initialize function**
  - Open external IRQ open function \( R_{ICU\_ExternalIRQ\_Open}() \)
  - Enable external IRQ (IRQ 2 additional in RA2E2)
- **DTC initialize function**
  - Open function \( R_{DTC\_Open}() \)
  - Enable DTC
- **DOC initialize function**
  - Open function \( R_{DOC\_Open}() \)
  - Initialize level judgement threshold storage variable
- **ELC initialize function**
  - Open function \( R_{ELC\_Open}() \)
  - Enable ELC
- **AGT0/1 initialize function**
  - When fast cycle debug is enabled
    - AGT period reset function \( R_{AGT\_Period\_Set}() \)
  - Only applicable for RA2E1.
  - Set interrupts
  - Set clocks, operating mode, and count mode
  - Initialize clock
- **RTC initialize function**
  - Initialize interrupts
  - Setting of Clocks, Operating mode, and Count mode
  - Initialize clock

Figure 45. Module Initialization Processing
Figure 46 shows the main loop processing flow.

- **Main loop**
  - All flags are cleared? (Yes/No)
  - **ADC conversion start event change function**
    - adc_scan_start_event_change()
  - **Pin state change function**
    - pin_state_change()
  - **Low power mode enter function**
    - _R_LPM_LowPowerModeEnter()
  - **Pin state change function**
    - pin_state_change()
  - **ADC conversion start event change function**
    - adc_scan_start_event_change()
  - **Manual LPM cancelling flag**
    - Clear
    - Set
    - Clear the flag
    - **Data output function**
      - data_output()
  - **Level judgement result flag**
    - Clear
    - Set
    - Clear the flag
    - **Data output function**
      - data_output()
  - **24-hour flag**
    - Clear
    - Set
    - Clear the flag
    - **Data output function**
      - data_output()
    - **RTC alarm setting function**
      - rtc_alarm_set()
  - **End**

- **Legend**
  - (a) Change the ADC conversion start event to Snooze request event
  - (b) Turn off the LED
  - (c) Enter to the low power mode
  - (d) Turn on the LED
  - (e) Change the ADC conversion start event to AGT1 underflow event
  - (f) Clear the manual LPM canceling flag
  - (g) Output data
  - (h) Clear the level judgement result flag
  - (i) Output data
  - (j) Clear the 24-hour flag
  - (k) Output data
  - (l) Set RTC alarm (only applicable for RA2E1)
Figure 47 shows the flow of RTC alarm interrupt processing.  
Note: RTC alarm interrupt processing is only applicable for RA2E1.

![RTC Alarm Interrupt Processing](image)

Figure 47. RTC Alarm Interrupt Processing

Figure 48 shows the flowchart for RA2E2 IRQ 2 interrupt processing.

![RA2E2 IRQ 2 Interrupt Processing](image)

Figure 48. RA2E2 IRQ 2 Interrupt Processing

Figure 49 shows the flowchart for IRQ interrupt processing.

![IRQ Interrupt Processing](image)

Figure 49. IRQ Interrupt Processing
Figure 50 shows the flowchart for DOC interrupt processing.

```
DOC interrupt
   doc_interrupt()

   Set level judgement result flag
   (a) Set level judgement result flag

   End
```

**Figure 50. DOC Interrupt Processing**

Figure 51 shows the SCI interrupt processing flow.

```
SCI uart interrupt
   sci_uart_interrupt()

   Transmit complete event
   No

   Yes

   Set transmit complete flag
   (a) Set transmit complete flag

   End
```

**Figure 51. SCI Interrupt Processing**
Figure 52 shows the flow of data processing.

![Data Processing Diagram](image)

**Figure 52. Data Processing**

4. **Evaluating Applications**

4.1 **Import and Building a Project**

To build an application project with e² studio IDE, proceed as follows:

1. Launch e² studio IDE.
2. Select any workspace in Workspace launcher.
3. Close Welcome window.
4. Select File > Import.
5. Select Existing Projects into Workspace from the Import dialog box.
7. Select the project you want to import and click Finish.
8. Open configuration.xml and click Generate Project Content in the Configurator window.
9. Select Project > Build Project.
4.2 Download and Debug a Project
To download and debug an application project using e² studio and onboard E2 emulator, proceed as follows:
1. Connect the connector CN6 of FPB-RA2E1 or FPB-RA2E2 and PC using USB cable.
2. Change setting of the header CN1 on the FPB-RA2E1 or FPB-RA2E2 to a debugger enabling setting (connect pin 1 and 2).
3. Open the Debug Configuration window.
4. Change settings as follows and as shown in Figure 53.
   - Debug hardware: E2 Lite (ARM)
   - Power Target From The Emulator: No
5. Clicking Debug

![Debug Configuration](image)

Figure 53. Debug Configuration

4.3 Procedure for Checking the Operation of the Low-Power Data Logger
To check the operation of the low-power data logger, proceed as follows:
1. Connect the FPB-RA2E1 or FPB-RA2E2 and PC using USB - TTL connector and jumper wires. Refer to section 3.2.2 for detailed connections.
2. Launch terminal software on the PC and change the settings as follows:
   - Transfer speed: 115,200 bps
   - Data length: 8 bits
   - Parity: None
   - Stop-bit length: 1 bit
3. Referring to section 4.5, change the setting of the header CN1 on the FPB-RA2E1 or FPB-RA2E2 to a free-run operation setting.
4. Power on the kit.
5. Confirm the operation.

This application project performs data output every 24 hours (every 24 minutes in fast cycle debug is enabled) (See Figure 54 or Figure 55). In addition, data output is executed when the values of the light sensor and temperature sensor exceed the threshold value (See Figure 56 or Figure 57). The output data can be viewed on terminal software on the PC. Furthermore, pressing the user switch S1 of the FPB-RA2E1 or FPB-RA2E2 kit will output the progress of accumulated measurement data at any time (See Figure 58 or Figure 59).
Note: A fast cycle debug is enabled

Figure 54. FPB-RA2E1 Example of Data Output Triggered by 24 Hours Passing

Note: A fast cycle debug is enabled

Figure 55. FPB-RA2E2 Example of Data Output Triggered by 24 Hours Passing

Note: A fast cycle debug is enabled

Figure 56. FPB-RA2E1 Example of Data Output Triggered by Analog Level Judgment Result
4.4 Evaluating the Current Consumption

FPB-RA2E1 or FPB-RA2E2 implements a resistor (R3) and test points (TP1 and TP2) for measuring the current of the MCU power of 3.3 V. When measuring the current amount of the MCU, remove resistor R3 and connect the measuring equipment to the test points.

See Figure 60 and Figure 61 for the location of TP1 and TP2.

![Figure 60. MCU Current Measuring Points (Circuit Diagram)](image)
4.5 Notes on Free-Running Operation with the FPB-RA2E1 or FPB-RA2E2 Kit

If the FPB-RA2E1 or FPB-RA2E2 is in Free-Run operation, connect pin 2 and 3 of the header CN1. Connecting these pins forces the onboard E2 emulator into a reset state, and it can operate alone without control from the IDE.

See Figure 62 for the location of CN1.

5. References

- Renesas FSP User's Manual [renesas.github.io/fsp]
- Renesas RA MCU datasheet Select the relevant MCUs from the [www.renesas.com/ra]
- Example Projects [github.com/renesas/ra-fsp-examples]
- Application Note: Getting Started with Low Power Applications for RA2L1/RA2E1 Group (R11AN0480)
- Application Note: Low Power Applications (Usage of ADC, DTC and ELC at Snooze Mode) for RA2E1(R30AN0392).
Website and Support

Visit the following URLs to learn about key elements of the RA family, download components and related documentation, and get support.

- **RA Product Information**: [www.renesas.com/ra](http://www.renesas.com/ra)
- **RA Product Support Forum**: [www.renesas.com/ra/forum](http://www.renesas.com/ra/forum)
- **RA Flexible Software Package**: [www.renesas.com/FSP](http://www.renesas.com/FSP)
- **Renesas Support**: [www.renesas.com/support](http://www.renesas.com/support)
## Revision History

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<td>1.00</td>
<td>Oct 12, 2021</td>
<td>-</td>
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<td>Initial version</td>
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<tr>
<td>1.10</td>
<td>May 11, 2022</td>
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<td>Added additional support for FPB-RA2E2</td>
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General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)
   A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on
   The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state
   Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins
   Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals
   After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. Voltage application waveform at input pin
   Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between $V_{IL}$ (Max.) and $V_{IH}$ (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between $V_{IL}$ (Max.) and $V_{IH}$ (Min.).

7. Prohibition of access to reserved addresses
   Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products
   Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.
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